S602ECS

RoHS



Main Features					
Symbol	Value	Unit			
I <sub>T(RMS)</sub>	1.5	А			
V <sub>DRM</sub> /V <sub>RRM</sub>	600	V			
I <sub>GT</sub>	100	μA			

# Applications

The S602ECS is specifically designed for Gas Ignition applications that require high pulse surge current capability.

# Absolute Maximum Ratings

#### Symbol Parameter Value Unit RMS on-state current $T_c = 65^{\circ}C$ А I<sub>T(RMS)</sub> 1.5 (full sine wave) $T_c = 65^{\circ}C$ 0.95 А Average on-state current I<sub>T(AV)</sub> F = 50 Hz14.0 Non repetitive surge peak on-state current А I<sub>TSM</sub> (Single cycle, $T_1$ initial = 25°C) F = 60 Hz16.8 t<sub>p</sub> = 10 ms 0.78 F = 50 Hzl²t I<sup>2</sup>t Value for fusing $\mathsf{A}^2\mathsf{s}$ F = 60 Hz t<sub>n</sub> = 8.3 ms 0.93 di/dt Critical rate of rise of on-state current IG = 10mA T\_ = 125°C 50 A/µs Peak gate current t<sub>0</sub> = 10 μs T\_= 125°C 1.0 А Ι<sub>GM</sub> W Average gate power dissipation T\_= 125°C 0.1 T<sub>stg</sub> °C -40 to 150 Storage junction temperature range -40 to 125 °C $T_{\perp}$ Operating junction temperature range

# Description

This new .8 A sensitive gate SCR in an TO-92 package with a GAK pin out, offers a high static component series with a high static dv/dt and a low turn off  $(t_q)$  time by the use of small die planar construction implementation. All SCR's junctions are glass-passivated to ensure long term reliability and parametric stability.

# Features

 $\leq 35 \ \mu s$ 

Surge capability >15AmpsHigh dv/dt noise immunity

• Improved turn-off time (t.)

- TO-92 G-A-K pinout
- Sensitive gate for direct microprocessor interface
- RoHS compliant and Halogen-Free

## Schematic Symbol



# Electrical Characteristics (T<sub>J</sub> = 25°C, unless otherwise specified)

Symbol	Description	Test Conditions	S602ECS		11
			Min	Max	Unit
I <sub>gt</sub>	DC Gate Trigger Current	V <sub>D</sub> = 12V	20	100	μA
V <sub>gt</sub>	DC Gate Trigger Voltage	$R_{L} = 60 \Omega$	_	0.8	V
V <sub>grm</sub>	Peak Reverse Gate Voltage	I <sub>RG</sub> = 10μA	5	—	V
I <sub>H</sub>	Holding Current	$R_{gK} = 1 \ k\Omega$	_	3	mA
(dv/dt)s	Critical Rate-of-Rise of Off-State Voltage	$\begin{array}{l} T_{\rm J} = 125^{\circ}{\rm C} \\ V_{\rm D} = V_{\rm DRM} / V_{\rm RRM} \\ {\rm Exponential Waveform} \\ R_{\rm GK} = 1 \ k\Omega \end{array}$	50	_	V/µs
t <sub>q</sub>	Turn-Off Time	$T_{J} = 125^{\circ}C @ 600 V$ $R_{GK} = 1 k\Omega$	_	35	μs
t <sub>gt</sub>	Turn-On Time	I <sub>G</sub> = 10mA PW = 15μsec I <sub>τ</sub> = 3.0A (pk)		3	μs

**Static Characteristics** (T<sub>J</sub> = 25°C, unless otherwise specified)

Symbol Description	Description	Test Conditions	Value		Unit
	Description		Min	Max	Onit
V <sub>TM</sub>	Peak On-State Voltage	I <sub>TM</sub> = 4A (pk)	_	1.8	V
I <sub>DRM</sub> Off-State (	Off-State Current, Peak Repetitive	$T_{J} = 25^{\circ}C @V_{D} = V_{DRM}$ $R_{GK} = 1 k\Omega$		5	μΑ
	On-State Current, reak nepetitive	$T_{J} = 125^{\circ}C @V_{D} = V_{DRM}$ $R_{GK} = 1 k\Omega$		500	μA

## **Thermal Resistances**

Symbol	Parameter		Value	Unit
R <sub>θ(J-C)</sub>	Junction to case (AC)	I <sub>T</sub> = 1.5A <sub>(RMS)</sub> , 60Hz AC resistive load condition, 100% conduction.	50	°C/W
R <sub>e(J-A)</sub>	Junction to ambient	condition, 100% conduction.	160	°C/W



# Figure 2: Normalized DC Holding Current vs. Junction Temperature



# **Thyristors** 1.5 Amp Sensitive SCRs







# Figure 4: On-State Current vs. On-State Voltage (Typical)



# Figure 6: Maximum Allowable Case Temperature vs. On-State Current



# Provide Provide



Supply Frequency: 60Hz Sinusoidal Load: Resistive RMS On-State Current [I<sub>TRMS</sub>]: Max Rated Value at Specific Case Temperature Notes: 1. Gate control may be lost during and immediately following surge current interval. 2. Overload may not be repeated until junction temperature has returned to steady-state rated value. Littelfuse<sup>®</sup> Power



# Figure 8: Typical DC Holding Current with RGK vs. Junction Temperature



# Figure 9: Typical Turn Off Time with RGK vs. Junction Temperature



Figure 10: Typical Static DV/DT with RGK vs. Junction Temperature



# **Soldering Parameters**

Reflow Condition		Pb – Free assembly	
	-Temperature Min (T <sub>s(min)</sub> )	150°C	
Pre Heat	-Temperature Max (T <sub>s(max)</sub> )	200°C	
	-Time (min to max) (t <sub>s</sub> )	60 – 180 secs	
Average ramp up rate (LiquidusTemp) (T <sub>L</sub> ) to peak		5°C/second max	
$T_{S(max)}$ to $T_L$	- Ramp-up Rate	5°C/second max	
Reflow	-Temperature (T <sub>L</sub> ) (Liquidus)	217°C	
	-Time (min to max) (t <sub>s</sub> )	60 – 150 seconds	
PeakTemperature (T <sub>P</sub> )		260 <sup>+0/-5</sup> °C	
Time within 5°C of actual peak Temperature (t <sub>p</sub> )		20 – 40 seconds	
Ramp-down Rate		5°C/second max	
Time 25°C to peak Temperature (T <sub>P</sub> )		8 minutes Max.	
Do not exceed		280°C	



# Physical Specifications Terminal Finish 100% Matte Tin-plated. Body Material UL Recognized epoxy meeting flammability rating V-0.

Copper Alloy

## **Design Considerations**

Lead Material

Careful selection of the correct component for the application's operating parameters and environment will go a long way toward extending the operating life of the Thyristor. Good design practice should limit the maximum continuous current through the main terminals to 75% of the component rating. Other ways to ensure long life for a power discrete semiconductor are proper heat sinking and selection of voltage ratings for worst case conditions. Overheating, overvoltage (including dv/dt), and surge currents are the main killers of semiconductors. Correct mounting, soldering, and forming of the leads also help protect against component damage.

# **Environmental Specifications**

Test	Specifications and Conditions
AC Blocking	MIL-STD-750, M-1040, Cond A Applied Peak AC voltage @ 125°C for 1008 hours
Temperature Cycling	MIL-STD-750, M-1051, 100 cycles; -40°C to +150°C; 15-min dwell-time
Temperature/ Humidity	EIA / JEDEC, JESD22-A101 1008 hours; 320V - DC: 85°C; 85% rel humidity
High Temp Storage	MIL-STD-750, M-1031, 1008 hours; 150°C
Low-Temp Storage	1008 hours; -40°C
Resistance to Solder Heat	MIL-STD-750 Method 2031
Solderability	ANSI/J-STD-002, category 3, Test A
Lead Bend	MIL-STD-750, M-2036 Cond E



## Dimensions



Dimensions	Inches		Millimeters	
Dimensions	Min	Max	Min	Max
А	0.175	0.205	4.450	5.200
В	0.170	0.210	4.320	5.330
С	0.500	—	12.700	—
D	0.135	—	3.430	—
E	0.125	0.165	3.180	4.190
F	0.080	0.105	2.040	2.660
G	0.016	0.021	0.407	0.533
Н	0.045	0.055	1.150	1.390
I	0.095	0.105	2.420	2.660
J	0.015	0.020	0.380	0.500

# **Packing Options**

Part Number	Marking	Weight	Packing Mode	Base Quantity
S602ECS	S602ECS	0.170 g	Bulk	2500
S602ECSAP	S602ECS	0.170 g	Ammo Pack	2000
S602ECSRP	S602ECS	0.170 g	Tape & Reel	2000

# Part Numbering System



# Part Marking System



# TO-92 (3-lead) Reel Pack (RP) Radial Leaded Specifications

# Meets all EIA-468-C Standards



# TO-92 (3-lead) Ammo Pack (AP) Radial Leaded Specifications

# Meets all EIA-468-C Standards



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